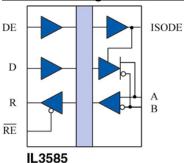


PROFIBUS Compatible Isolated RS485 Interface

Functional Diagram



V _{ID} (A-B)	DE	RE	R	D	Mode
$\geq 200 \; mV$	L	L	Н	X	Receive
\leq -200 mV	L	L	L	X	Receive
≥ 1.5 V	Н	L	Н	Н	Drive
≤ -1.5 V	Н	L	L	L	Drive
X	X	Н	Z	X	Hi Z R

Features

- 3.3 / 5 V Input Supply Compatible
- 2500 V_{RMS} Isolation (1 minute)
- 20 ns Propagation Delay
- 40 Mbps Data Rate
- 5 ns Pulse Skew
- 20 kV/µs Transient Immunity
- Thermal Shutdown Protection
- -40°C to +85°C Temperature Range
- PROFIBUS Compliant
- 16-pin SOIC Package
- UL1577 Approval
- IEC 61010-2001 Approval

Applications

- Security Networks
- PROFIBUS DP and FMS Networks
- Building Environmental Controls
- Industrial Control Networks
- Gaming Systems
- Factory Automation

Description

The IL3585 is a galvanically isolated, high-speed differential bus transceiver, designed for bi-directional data communication on balanced transmission lines. Isolation is achieved through patented* IsoLoop technology. The IL3585 offers an exceptional 2.3 V differential output into a 54 Ω load, over the supply range of 4.5 V to 5.5 V. This means better data integrity over longer cable lengths, even at data rates as high as 40 Mbps. The device is also compatible with 3.3V input supplies, allowing interface to standard microcontrollers without the need for additional level shifting components.

The IL3585 has current limiting and thermal shutdown features to protect against output short circuits and bus contention situations that may cause excessive power dissipation. Receiver inputs feature a "fail-safe if open" design, which ensures a logic high R-output if A/B are floating.





Absolute Maximum Ratings(11)

Parameters	Symbol	Min.	Typ.	Max.	Units	Test Conditions
Storage Temperature	T_{s}	-65		150	°C	
Ambient Operating Temperature	T_{A}	-40		100	°C	
Voltage Range at A or B Bus Pins		-7		12	V	
Supply Voltage (1)	$V_{\mathrm{DD1}}, V_{\mathrm{DD2}}$	-0.5		7	V	
Digital Input Voltage		-0.5		$V_{DD} + 0.5$	V	
Digital Output Voltage		-0.5		$V_{DD} + 1$	V	

Recommended Operating Conditions

Parameters	Symbol	Min.	Тур.	Max.	Units	Test Conditions
Supply Voltage	$V_{ ext{DD1}}$	3.0		5.5	V	
,	$ m V_{DD2}$	4.5		5.5		
Input Voltage at any Bus Terminal	V _I			12	V	
(separately or common mode)	$V_{\rm IC}$			-7		
High-Level Digital Input Voltage	$V_{\scriptscriptstyle \mathrm{IH}}$	2.4			V	$V_{DD1} = 3.3 \text{ V}$
		3.0				$V_{DD1} = 5.0 \text{ V}$
Low-Level Digital Input Voltage	$V_{\scriptscriptstyle IL}$			0.8	V	
Differential Input Voltage (2)	$V_{\scriptscriptstyle { m ID}}$			+12 / -7	V	
High-Level Output Current (Driver)	I_{OH}	-60		60	mA	
High-Level Digital Output Current	I_{OH}	-8		8	mA	
(Receiver)						
Low-Level Output Current (Driver)	I_{OL}	-60		60	mA	
Low-Level Digital Output Current	I_{OL}	-8		8	mA	
(Receiver)						
Ambient Operating Temperature	T _A	-40		85	°C	
Digital Input Signal Rise and Fall	t_{IR}, t_{IF}			DC St	able	
Times						

Insulation Specifications

Parameters	Symbol	Min.	Тур.	Max.	Units	Test Conditions
Creepage Distance (external)		8.077			mm	
Barrier Impedance			$> 10^{14} 7$		$\Omega \parallel pF$	
Leakage Current			0.2		μA_{RMS}	$240 \text{ V}_{\text{RMS}}, 60 \text{ Hz}$

Safety & Approvals

IEC61010-2001

TUV Certificate Numbers: N1502812, N1502812-101

Classification: Reinforced Insulation

Model	Package	Pollution Degree	Material Group	Max. Working Voltage
IL3585	SOIC (0.3")	II	III	$300~\mathrm{V_{RMS}}$

UL 1577

Component Recognition program. File #: E207481 Rated $2500V_{RMS}$ for 1 minute (SOIC)

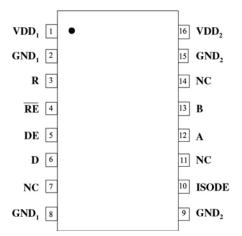
Electrostatic Discharge Sensitivity

This product has been tested for electrostatic sensitivity to the limits stated in the specifications. However, NVE recommends that all integrated circuits be handled with appropriate care to avoid damage. Damage caused by inappropriate handling or storage could range from performance degradation to complete failure.

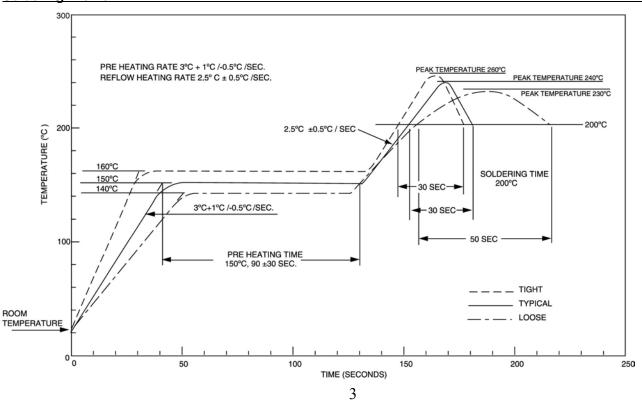


Pin Connections

	ilections	
1	V_{DD1}	Input power supply
2	GND_1	Input power supply ground return. (pin 2 is internally connected to pin 8)
3	R	Output data from bus
4	RE	Read data enable (if RE is high, R= high impedance)
5	DE	Drive enable
6	D	Data input to bus
7	NC	No internal connection
8	GND_1	Input power supply ground return. (pin 8 is internally connected to pin 2)
9	GND_2	Output power supply ground return. (pin 9 is internally connected to pin 15)
10	ISODE	Isolated DE output for us in PROFIBUS applications where the state of the isolated drive enable node needs to be monitored.
11	NC	No internal connection
12	A	Non-inverting bus line
13	В	Inverting bus line
14	NC	No internal connection
15	GND ₂	Output power supply ground return. (pin 15 is internally connected to pin 9)
16	V_{DD2}	Output power supply



Soldering Profile





Driver Section

Electrical Specifications are T_{min} to T_{max} unless otherwise stated.

Parameters	Symbol	Min.	Typ. ⁽⁵⁾	Max.	Units	Test Conditions
Input Clamp Voltage	V_{IK}			-1.5	V	$I_L = -18 \text{ mA}$
Output voltage	V_{o}			$V_{\scriptscriptstyle m DD}$	V	$I_{O} = 0$
Differential Output Voltage ⁽²⁾	$ V_{OD1} $			$V_{\scriptscriptstyle DD}$	V	$I_0 = 0$
Differential Output Voltage ⁽²⁾	$ V_{\mathrm{OD2}} $	2.5	3	5	V	$R_L = 54 \Omega, V_{DD} = 5 V$
Differential Output Voltage ⁽²⁾⁽⁶⁾	V_{OD3}	2.3		5	V	$R_L = 54 \Omega, V_{DD} = 4.5 V$
Change in Magnitude of Differential Output Voltage ⁽⁷⁾	$\Delta V_{ m OD} $			±0.2	V	$R_L = 54 \Omega \text{ or } 100 \Omega$
Common Mode Output Voltage	V_{oc}			3	V	$R_L = 54 \Omega \text{ or } 100 \Omega$
Change in Magnitude of Common Mode Output Voltage ⁽⁷⁾	$\Delta V_{\rm oc} $			±0.2	V	$R_L = 54 \Omega \text{ or } 100 \Omega$
Output Current ⁽⁴⁾	I_{o}			1 -0.8	mA	Output Disabled, $V_0 = 12$ $V_0 = -7$
High Level Input Current	I_{IH}			10	μΑ	$V_1 = 3.5 \text{ V}$
Low Level Input Current	$I_{\rm IL}$			-10	μΑ	$V_1 = 0.4 \text{ V}$
Absolute Short-circuit Output Current	I_{OS}	60		250	μΑ	$-7 \text{ V} > \text{V}_{\text{o}} < 12 \text{ V}$
Supply Current $(V_{DD2} = +5 V)$	I_{DD2}		5	8	mA	No Load
$(V_{DD1} = +5 V)$	$I_{ m DD1}$		4	6		(Outputs Enabled)
$(V_{DD1} = +3.3 \text{ V})$	I_{DD1}		3	4		
		Switching Spe	cifications (5)	1	T	
Parameters	Symbol	Min.	Typ. ⁽⁵⁾	Max.	Units	Test Conditions
Data Rate		40			Mbps	$R_L = 54 \Omega, C_L = 50 \text{ pF}$
Differential Output Prop Delay	$t_{D}(OD)$		20	30	ns	$R_L = 54 \Omega, C_L = 50 \text{ pF}$
Pulse Skew ⁽¹⁰⁾	$t_s(P)$		1	6	ns	$R_L = 54 \Omega, C_L = 50 pF$
Differential Output Rise & Fall Time	$t_T(OD)$		5	8	ns	$R_L = 54 \Omega, C_L = 50 pF$
Output Enable Time To High Level	$t_{ m PZH}$		20	30	ns	$R_L = 54 \Omega, C_L = 50 pF$
Output Enable Time To Low Level	$t_{ m PZL}$		20	30	ns	$R_L = 54 \Omega, C_L = 50 \text{ pF}$
Output Disable Time From High Level	$t_{ m PHZ}$		20	30	ns	$R_L = 54 \Omega, C_L = 50 \text{ pF}$
Output Disable Time From Low Level	$t_{\scriptscriptstyle PLZ}$		20	30	ns	$R_L = 54 \Omega, C_L = 50 \text{ pF}$
Skew Limit ⁽³⁾	$t_{SK}(LIM)$		2	12	ns	$R_L = 54 \Omega, C_L = 50 \text{ pF}$

Notes: These apply to both driver and receiver sections

- 1. All Voltage values are with respect to network ground except differential I/O bus voltages.
- 2. Differential input/output voltage is measured at the noninverting terminal A with respect to the inverting terminal B.
- 3. Skew limit is the maximum propagation delay difference between any two devices at 25°C.
- The power-off measurement in ANSI Standard EIA/TIA-422-B applies to disabled outputs only and is not applied to combined inputs and outputs.
- 5. All typical values are at V_{DD1} , $V_{DD2} = 5$ V or $V_{DD1} = 3.3$ V and $T_A = 25$ °C.
- 6. While $-7 \text{ V} < V_{CM} > 12 \text{ V}$, the minimum V_{OD2} with a 54 Ω load is either $\frac{1}{2} V_{OD1}$ or 2.3 V, whichever is greater.
- 7. $\Delta |V_{\text{OD}}|$ and $\Delta |V_{\text{OC}}|$ are the changes in magnitude of V_{OD} and V_{OC} , respectively, that occur when the input is changed form one logic state to the other.
- 8. This applies for both power on and power off, refer to ANSI standard RS-485 for exact condition. The EIA/TIA-422-B limit does not apply for a combined driver and receiver terminal.
- 9. Includes 10 ns read enable time. Maximum propagation delay is 25 ns after read assertion.
- 10. Pulse skew is defined as the $|t_{PLH} t_{PHL}|$ of each channel.
- 11. Absolute Maximum specifications mean the device will not be damaged if operated under these conditions. It does not guarantee performance.



Receiver Section Electrical Specification

Electrical Specifications are T_{min} to T_{max} un			(5)	T		
Parameters	Symbol	Min.	Typ. ⁽⁵⁾	Max.	Units	Test Conditions
Positive-going Input Threshold Voltage	$V_{\rm IT^+}$			0.2	V	$-7 \text{ V} > \text{V}_{\text{CM}} < 12 \text{ V}$
Negative-going Input Threshold Voltage	V _{IT} -	-0.2			V	$-7 \text{ V} > \text{V}_{\text{CM}} < 12 \text{ V}$
Hysteresis Voltage (V _{IT+} - V _{IT-})	$V_{\scriptscriptstyle \mathrm{HYS}}$		40		mV	$V_{CM} = 0 \text{ V, } T = 25^{\circ}\text{C}$
High Level Digital Output Voltage	$ m V_{OH}$	$V_{DD} - 0.2$	V_{DD}		V	$V_{ID} = 200 \text{ mV}$ $I_{OH} = -20 \mu A$
Low Level Digital Output Voltage	$V_{\scriptscriptstyle OL}$			0.2	V	$V_{ID} = -200 \text{ mV}$ $I_{OH} = 20 \mu\text{A}$
High-impedance-state output current	I_{OZ}			±1	μΑ	$V_0 = 0.4 \text{ to } (V_{DD2} - 0.5)$
Line Input Current ⁽⁸⁾	$I_{\rm I}$			1	mA	$V_{I} = 12 \text{ V}$
				-0.8	mA	$V_{I} = -7 \text{ V}$
Input Resistance	R_{I}	20			kΩ	
Supply Current $(V_{DD2} = +5V)$	I_{DD2}		5	8	mA	No load Outputs
$(V_{DD1} = +5V)$	$I_{ m DD1}$		4	6		Enabled
$(V_{DD1} = +3.3V)$	I_{DD1}		3	4		
	Switching Cha	racteristics (V ₁		$_{\rm DD2} = +5 \text{ V}$		
Parameters	Symbol	Min.	Typ. ⁽⁵⁾	Max.	Units	Test Conditions
Data Rate		40			Mbps	$R_{L} = 54 \Omega, C_{L} = 50 pF$
Propagation Delay ⁽⁹⁾	$t_{ m PD}$		27	35	ns	$V_o = -1.5 \text{ to } 1.5 \text{ V},$ $C_L = 15 \text{ pF}$
Pulse Skew ⁽¹⁰⁾	$t_{SK}(P)$		1	6	ns	$V_0 = -1.5 \text{ to } 1.5 \text{ V},$ $C_L = 15 \text{ pF}$
Skew Limit ⁽³⁾	$t_{SK}(LIM)$		2	12	ns	$R_L = 54 \Omega, C_L = 50 \text{ pF}$
Output Enable Time To High Level	t_{PZH}		15	25	ns	$C_L = 15 \text{ pF}$
Output Enable Time To Low Level	$t_{\scriptscriptstyle \mathrm{PZL}}$		15	25	ns	$C_L = 15 \text{ pF}$
Output Disable Time From High Level	$t_{\scriptscriptstyle ext{PHZ}}$		15	25	ns	$C_L = 15 \text{ pF}$
Output Disable Time From Low Level	$t_{\scriptscriptstyle{\mathrm{PLZ}}}$		15	25	ns	$C_L = 15 \text{ pF}$
	Switching Char	racteristics (V _{DI}	$_{01} = +3.3 \text{ V}, \text{ V}$	$_{\mathrm{DD2}} = +5 \mathrm{V})$		
Parameters	Symbol	Min.	Typ. ⁽⁵⁾	Max.	Units	Test Conditions
Data Rate		40			Mbps	$R_{L} = 54 \Omega, C_{L} = 50 pF$
Propagation Delay ⁽⁹⁾	$t_{ ext{PD}}$		30	38	ns	$V_0 = -1.5 \text{ to } 1.5 \text{ V},$ $C_L = 15 \text{ pF}$
Pulse Skew ⁽¹⁰⁾	$t_{SK}(P)$		1	6	ns	$V_0 = -1.5 \text{ to } 1.5 \text{ V},$ $C_L = 15 \text{ pF}$
Skew Limit ⁽³⁾	$t_{SK}(LIM)$		4	12	ns	$R_L = 54 \Omega, C_L = 50 \text{ pF}$
Output Enable Time To High Level	$t_{ m PZH}$		17	27	ns	$C_L = 15 \text{ pF}$
Output Enable Time To Low Level	t _{PZL}		17	27	ns	$C_L = 15 \text{ pF}$
Output Disable Time From High Level	$t_{\rm PHZ}$		17	27	ns	$C_L = 15 \text{ pF}$
Output Disable Time From Low Level	t_{PLZ}		17	27	ns	$C_L = 15 \text{ pF}$



Power Consumption

Isoloop devices achieve their low power consumption by detecting the edge transitions of the input logic signal and converting these to narrow current pulses. This technique creates a supply current which is proportional to data rate, which has obvious advantages over optocouplers whose power consumption is dependent on mark:space ratio.

Table 2. Typical Dynamic Supply Currents.

Data Rate (Mbps)	I_{DD1}	I_{DD2}
1	300 μΑ	300 μΑ
10	3 mA	3 mA
20	6 mA	6 mA
40	12 mA	12 mA

Power Supplies

It is required that low ESR capacitors such as ceramic are used to decouple the supplies. Both V_{DD1} and V_{DD2} must be bypassed with 47 nF capacitors. These should be placed as close as possible to V_{DD} pins for proper operation. In addition, V_{DD2} should have a 10 μ F tantalum capacitor connected in parallel with the 47 nF capacitor.

DC Correctness

The IL3585 incorporates a patented refresh circuit which effectively maintains the correct output state with respect to data input. At power up, the bus outputs will follow the Function Table shown on Page 1. It is recommended that the DE input is always held low during power up to eliminate false drive data pulses from the bus. The use of an external power supply monitor to minimize glitches caused by slow power-up and power-down transients is not required.

Application Information

Receiver Features

The IL3585 receiver includes a "fail-safe if open" function that guarantees a <u>high</u> level receiver output if the receiver inputs are unconnected (floating). IL3585 receiver outputs have tri-state capability via the active low RE input.

Driver Features

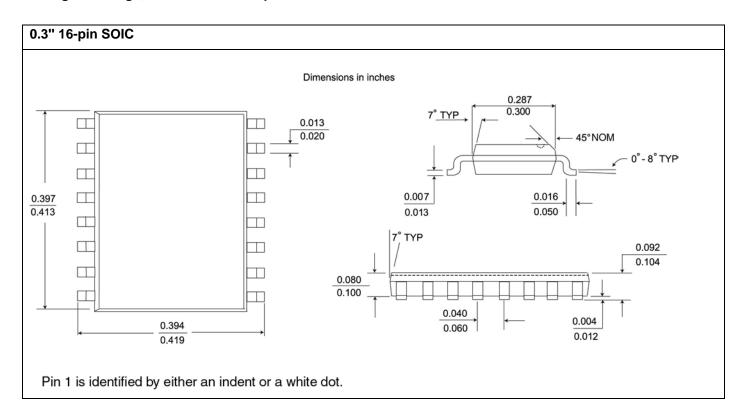
The RS-485 driver is a differential output device that delivers at least 1.5 V across a 54 Ω load. The drivers feature low propagation delay skew to maximize bit width and to minimize EMI. The IL3585 drivers have tri-state capability via the active high DE input.

Receiver Data Rate, Cables and Terminations

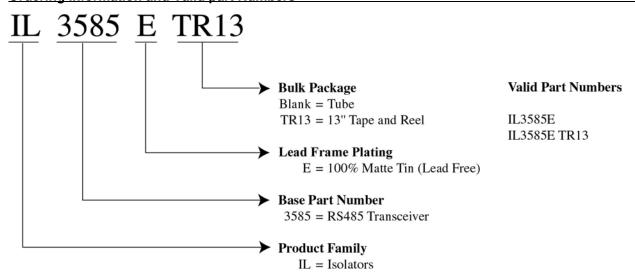
This device is intended for network lengths up to 4000', but the maximum system data rate decreases as the transmission line length increases. Twisted pair cable should be used in all networks since they tend to pick up noise and other electromagnetically induced voltages as common mode signals, which are effectively rejected by the differential receivers in these ICs.



Package Drawings, Dimensions and Specifications



Ordering Information and Valid part Numbers





Revision History

ISB-DS-001-IL3585-C

Changes

- 1. UL File Number and TUV Certificate numbers added to page two
- 2. Soldering Profile added.
- 3. Leaded parts option removed.
- 4. 0.3" parts diagram dimensions updated



About NVE

An ISO 9001 Certified Company

NVE Corporation is a high technology components manufacturer having the unique capability to combine leading edge Giant Magnetoresistive (GMR) materials with integrated circuits to make high performance electronic components. Products include Magnetic Field Sensors, Magnetic Field Gradient Sensors (Gradiometer), Digital Magnetic Field Sensors, Digital Signal Isolators and Isolated Bus Transceivers.

NVE is a leader in GMR research and in 1994 introduced the world's first products using GMR material, a line of GMR magnetic field sensors that can be used for position, magnetic media, wheel speed and current sensing.

NVE is located in Eden Prairie, Minnesota, a suburb of Minneapolis. Please visit our Web site at www.nve.com or call 952-829-9217 for information on products, sales or distribution.

NVE Corporation 11409 Valley View Road Eden Prairie, MN 55344-3617 USA Telephone: (952) 829-9217

Fax: (952) 829-9189 Internet: www.nve.com e-mail: isoinfo@nve.com

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Specifications shown are subject to change without notice.

ISB-DS-001-IL3585-C

November 23, 2005